AUTOMOTIVE GRADE

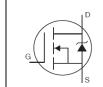


AUIRLR2905Z

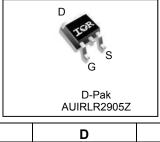
HEXFET[®] Power MOSFET

Features

- Advanced Process Technology
- Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified *



V _{DSS}	55V
R _{DS(on)} max.	13.5mΩ
D (Silicon Limited)	60A
D (Package Limited)	42A



Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.

		D-Pak AUIRLR2905Z	
G		D	S
Gate		Drain	Source

Bees nort number	Dookogo Turo	Standard Pack		Orderable Part Number
Base part number Package Type Form		Quantity	Orderable Part Number	
AUIRLR2905Z	D Dek	Tube	75	AUIRLR2905Z
AUIRLR29052	D-Pak	Tape and Reel Left	3000	AUIRLR2905ZTRL

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	60	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	43	
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Package Limited)	42	A
I _{DM}	Pulsed Drain Current ①	240	
P _D @T _C = 25°C	Maximum Power Dissipation	110	W
	Linear Derating Factor	0.72	W/°C
V _{GS}	Gate-to-Source Voltage	± 16	V
E _{AS}	Single Pulse Avalanche Energy (Thermally Limited) 2	57	m
E _{AS} (Tested)	Single Pulse Avalanche Energy Tested Value 6	85	mJ
I _{AR}	Avalanche Current ①	See Fig.15,16, 12a, 12b	A
E _{AR}	Repetitive Avalanche Energy S		mJ
TJ	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
R _{θJC}	Junction-to-Case ®		1.38	
$R_{ heta JA}$	Junction-to-Ambient (PCB Mount) 🗇		50	°C/W
$R_{ heta JA}$	Junction-to-Ambient		110	

HEXFET® is a registered trademark of Infineon.

*Qualification standards can be found at www.infineon.com



AUIRLR2905Z

Static @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	55			V	V _{GS} = 0V, I _D = 250µA
$\Delta V_{(BR)DSS} / \Delta T_J$	Breakdown Voltage Temp. Coefficient		0.053		V/°C	Reference to 25°C, I _D = 1mA
			11	13.5		V _{GS} = 10V, I _D = 36A ③
R _{DS(on)}	Static Drain-to-Source On-Resistance			20		V _{GS} = 5.0V, I _D = 30A ③
				22.5		V _{GS} = 4.5V, I _D = 15A ③
V _{GS(th)}	Gate Threshold Voltage	1.0		3.0	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
gfs	Forward Trans conductance	25			S	V _{DS} = 25V, I _D = 36A ③
1	Drain to Source Lookage Current			20	μA	V _{DS} = 55V, V _{GS} = 0V
IDSS	Drain-to-Source Leakage Current			250	μΑ	V _{DS} = 55V,V _{GS} = 0V,T _J =125°C
	Gate-to-Source Forward Leakage			200	54	V _{GS} = 16V
I _{GSS}	Gate-to-Source Reverse Leakage			-200	nA	V _{GS} = -16V

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

-	·		-	-		
Q_{g}	Total Gate Charge		23	35		I _D = 36A
Q_{gs}	Gate-to-Source Charge		8.5		nC	V _{DS} = 44V
Q_gd	Gate-to-Drain Charge		12			V _{GS} = 5.0V③
t _{d(on)}	Turn-On Delay Time		14			$V_{DD} = 28V$
t _r	Rise Time		130		-	I _D = 36A
t _{d(off)}	Turn-Off Delay Time		24		ns	$R_{G} = 15\Omega$
t _f	Fall Time		33			V _{GS} = 5.0V③
L _D	Internal Drain Inductance		4.5		nH	Between lead, 6mm (0.25in.)
L _S	Internal Source Inductance		7.5		1111	from package and center of die contact
C _{iss}	Input Capacitance		1570			V _{GS} = 0V
Coss	Output Capacitance		230			V _{DS} = 25V
C _{rss}	Reverse Transfer Capacitance		130		pF	<i>f</i> = 1.0MHz
C _{oss}	Output Capacitance		840		pΓ	$V_{GS} = 0V, V_{DS} = 1.0V f = 1.0MHz$
C _{oss}	Output Capacitance		180			$V_{GS} = 0V, V_{DS} = 44V f = 1.0MHz$
C _{oss eff.}	Effective Output Capacitance		290			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 44V \oplus$
Diode Chara	acteristics					
	Parameter	Min.	Тур.	Max.	Units	Conditions
	Continuous Source Current			42		MOSFET symbol

	Parameter	win.	тур.	wax.	Units	Conditions
I _S	Continuous Source Current (Body Diode)			42		MOSFET symbol showing the
I _{SM}	Pulsed Source Current (Body Diode) ①			240		integral reverse $a = \frac{1}{2}$
V _{SD}	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 36A, V_{GS} = 0V$ (3)
t _{rr}	Reverse Recovery Time		22	33	ns	T _J = 25°C ,I _F = 36A, V _{DD} = 28V
Q _{rr}	Reverse Recovery Charge		14	21	nC	di/dt = 100A/µs ③
t _{on}	Forward Turn-On Time	Intrinsic	turn-or	time is	negligil	ble (turn-on is dominated by $L_{S}+L_{D}$)

Notes:

① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)

2 Limited by T_{Jmax}, starting T_J = 25°C, L = 0.089mH, R_G = 25Ω, I_{AS} = 36A, V_{GS} = 10V. Part not recommended for use above this value.
 3 Pulse width ≤ 1.0ms; duty cycle ≤ 2%.

 \oplus C_{oss} eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}

© Limited by T_{Jmax}, see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.

[©] This value determined from sample failure population, starting $T_J = 25^{\circ}C$, L = 0.089mH, R_G = 25Ω, I_{AS} = 36A, V_{GS} = 10V.

When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994

 \circledast R_{θ} is measured at T_J approximately 90°C.



VGS 10V 9.0V 7.0V

5.0V 4.5V 4.0V

3.5V 3.0V

100

ТОР

воттом

≤ 60µs PULSE WIDTH

10

. Tj = 175°C

1

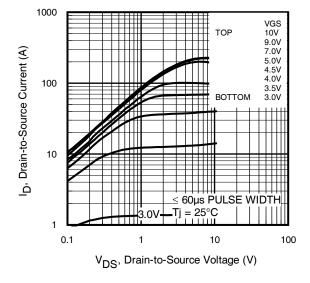


Fig. 1 Typical Output Characteristics

Fig. 2 Typical Output Characteristics

 V_{DS} , Drain-to-Source Voltage (V)

1000

100

10

1 **L**

I_D, Drain-to-Source Current (A)

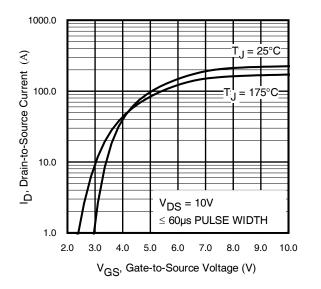


Fig. 3 Typical Transfer Characteristics

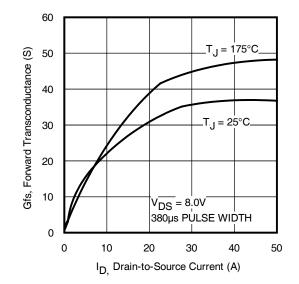
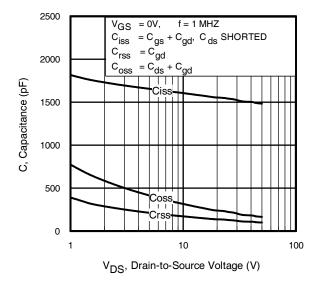


Fig. 4 Typical Forward Trans conductance Vs. Drain Current







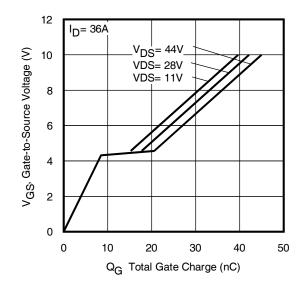


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

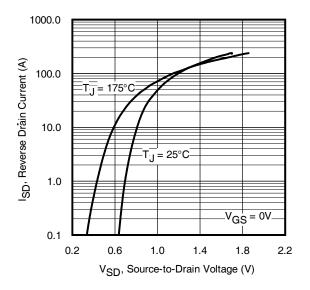


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

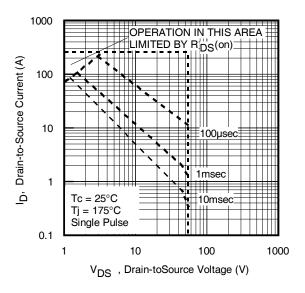
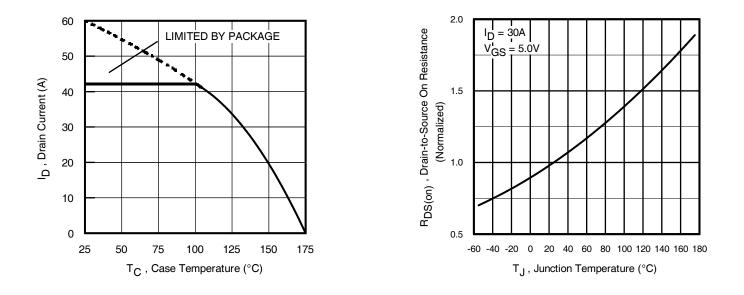
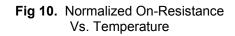


Fig 8. Maximum Safe Operating Area









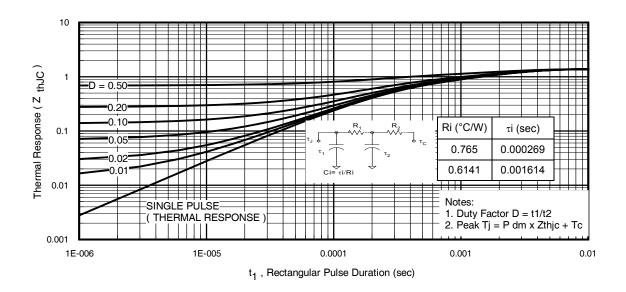


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

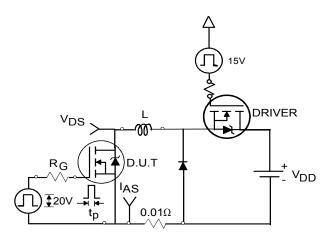


Fig 12a. Unclamped Inductive Test Circuit

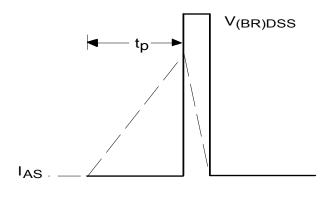


Fig 12b. Unclamped Inductive Waveforms

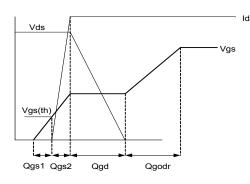


Fig 13a. Gate Charge Waveform

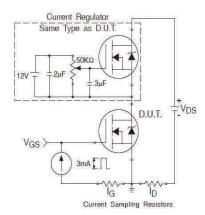
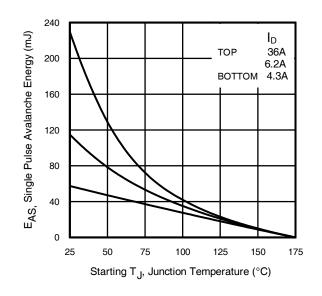
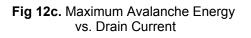


Fig 13b. Gate Charge Test Circuit





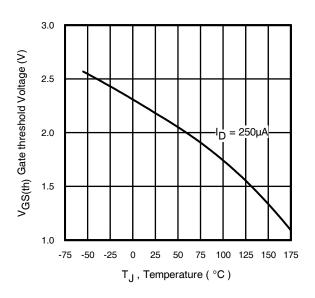


Fig 14. Threshold Voltage Vs. Temperature



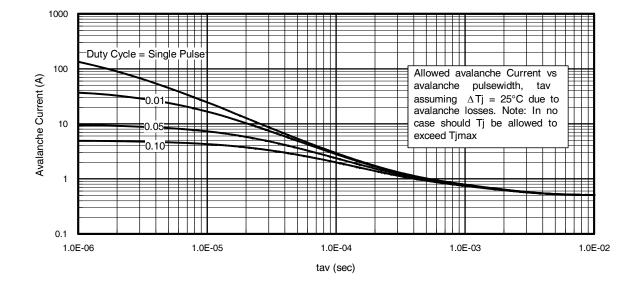
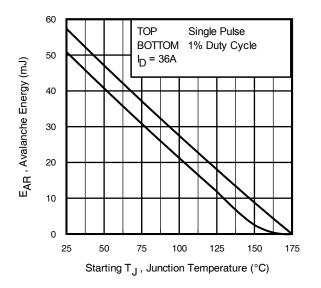
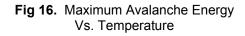


Fig 15. Typical Avalanche Current Vs. Pulse width





Notes on Repetitive Avalanche Curves , Figures 15, 16:

(For further info, see AN-1005 at www.infineon.com)

- Avalanche failures assumption: Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{imax}. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long as T_{jmax} is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
- 4. PD (ave) = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. Iav = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 15, 16).

tav = Average time in avalanche.

D = Duty cycle in avalanche = tav ·f

ZthJC(D, tav) = Transient thermal resistance, see Figures 13)

$$\begin{split} \textbf{P}_{D (ave)} &= 1/2 \; (\; \textbf{1.3} \cdot \textbf{BV} \cdot \textbf{I}_{av}) = \Delta T/ \; \textbf{Z}_{thJC} \\ \textbf{I}_{av} &= 2\Delta T/ \; [\textbf{1.3} \cdot \textbf{BV} \cdot \textbf{Z}_{th}] \\ \textbf{E}_{AS (AR)} &= \textbf{P}_{D (ave)} \cdot \textbf{t}_{av} \end{split}$$



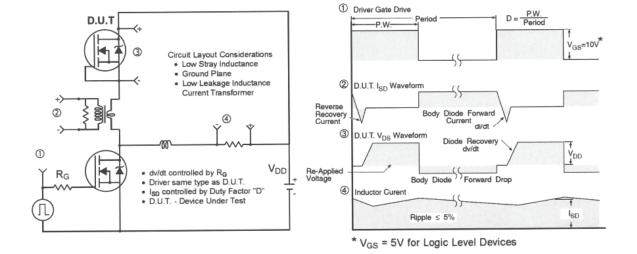


Fig 17. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET $\ensuremath{\mathbb{R}}$ Power MOSFETs

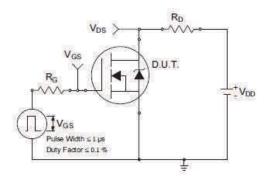


Fig 18a. Switching Time Test Circuit

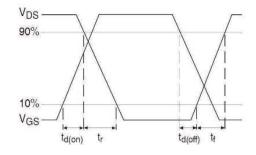
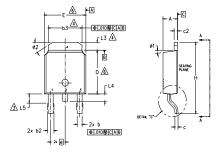


Fig 18b. Switching Time Waveforms

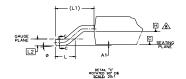


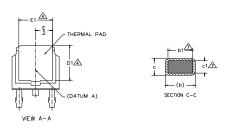
AUIRLR2905Z

D-Pak (TO-252AA) Package Outline (Dimensions are shown in millimeters (inches))









NOTES:

- 1.- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2.- DIMENSION ARE SHOWN IN INCHES [MILLIMETERS].
- A- LEAD DIMENSION UNCONTROLLED IN L5.
- A- DIMENSION D1, E1, L3 & 63 ESTABLISH A MINIMUM MOUNTING SURFACE FOR THERMAL PAD.
- 5.- SECTION C-C DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN .005 AND 0.10 [0.13 AND 0.25] FROM THE LEAD TIP.
- ▲ DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005 [0.13] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- A- DIMENSION 61 & c1 APPLIED TO BASE METAL ONLY.
- A- DATUM A & B TO BE DETERMINED AT DATUM PLANE H.

9.–	OUTLINE	CONFORMS	ΤO	JEDEC	OUTLINE	TO-252AA.	

S Y M						
B O	MILLIM	ETERS	INC	HES	0 T	
0 L	MIN.	MAX.	MIN.	MAX.	E S	
Α	2.18	2.39	.086	.094		
A1	-	0.13	-	.005		
b	0.64	0.89	.025	.035		
ь1	0.65	0.79	.025	.031	7	
b2	0.76	1.14	.030	.045		
b3	4.95	5.46	.195	.215	4	
с	0.46	0.61	.018	.024		
c1	0.41	0.56	.016	.022	7	
c2	0.46	0.89	.018	.035		
D	5.97	6.22	.235	.245	6	
D1	5.21	-	.205	-	4	
Е	6.35	6.73	.250	.265	6	
E1	4.32	-	.170	-	4	
е	2.29	BSC	.090	BSC		
н	9.40	10.41	.370	.410		
L	1.40	1.78	.055	.070		
L1	2.74	BSC	.108	REF.		
L2	0.51	BSC	.020	.020 BSC		
L3	0.89	1.27	.035	.050	4	
L4	-	1.02	-	.040		
L5	1.14	1.52	.045	.060	3	
ø	0.	10 °	0.	10°		
ø1	0.	15 °	0.	15*		
ø2	25'	35*	25*	35*		

LEAD ASSIGNMENTS

<u>HEXFET</u>

1.- GATE 2.- DRAIN 3.- SOURCE 4.- DRAIN

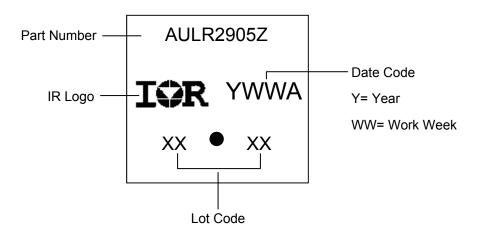
IGBT & CoPAK

1.- GATE

2.- COLLECTOR 3.- EMITTER

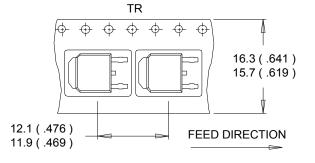
4.- COLLECTOR

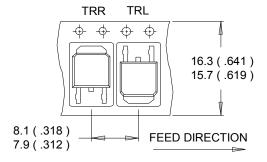
D-Pak (TO-252AA) Part Marking Information



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

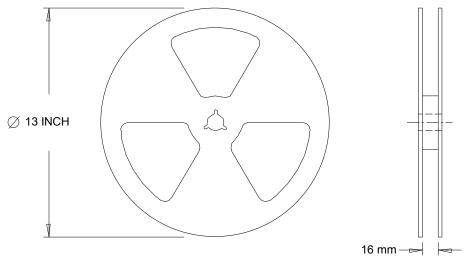
D-Pak (TO-252AA) Tape & Reel Information (Dimensions are shown in millimeters (inches))





NOTES :

- 1. CONTROLLING DIMENSION : MILLIMETER.
- 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
- 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



NOTES : 1. OUTLINE CONFORMS TO EIA-481.

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



Qualification Information

Qualification Level		Automotive (per AEC-Q101)	
		Comments: This part number(s) passed Automotive qualification. Infineon's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.	
Moisture Sensitivity Level		D-Pak	MSL1
ESD	Machine Model	Class M2 (+/- 200V) [†]	
		AEC-Q101-002	
	Human Body Model		Class H1B (+/-1000V) [†]
		AEC-Q101-001	
	Charged Device Model	Class C5 (+/-1125V) [†]	
		AEC-Q101-005	
RoHS Compliant		Yes	

+ Highest passing voltage.

Revision History

Date	Comments		
12/11/2015	 Updated datasheet with corporate template Corrected ordering table on page 1. Corrected typo R_{0JA} (PCB mount) from "40°C/W" to "50°C/W" on page 1. 		

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